

<b>Notice of References Cited</b>	Application/Control No. 10/781,102	Applicant(s)/Patent Under Reexamination FIDOCK, MARK D.	
	Examiner Tekchand Saidha	Art Unit 1652	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,885,834	03-1999	Epstein, Paul M.	435/375
	B	US-5,389,527	02-1995	Beavo et al.	435/69.1
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	sequence alignment between Applicants' SEQ ID NO: 1 and Epstein's Accession Number AAW95110 (or SEQ ID NO: 2)
	V	sequence alignment between Applicants' SEQ ID NO: 1 and Beavo et al. Accession Number AAR69720 (or SEQ ID NO: 27)
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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